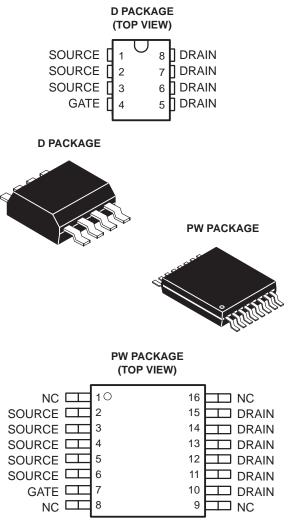
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- Low $r_{DS(on)}$. . . 0.09 Ω Typ at V_{GS} = -10 V
- **3 V Compatible**
- **Requires No External V_{CC}**
- **TTL and CMOS Compatible Inputs**
- $V_{GS(th)} = -1.5 V Max$
- Available in Ultrathin TSSOP Package (PW)
- ESD Protection Up to 2 kV per MIL-STD-883C, Method 3015

description

The TPS1101 is a single, low- $r_{DS(on)}$, P-channel, enhancement-mode MOSFET. The device has been optimized for 3-V or 5-V power distribution in battery-powered systems by means of the Texas Instruments LinBiCMOS™ process. With a maximum V_{GS(th)} of -1.5 V and an I_{DSS} of only 0.5 µA, the TPS1101 is the ideal high-side switch for low-voltage, portable battery-management systems where maximizing battery life is a primary concern. The low r_{DS(on)} and excellent ac characteristics (rise time 5.5 ns typical) of the TPS1101 make it the logical choice for low-voltage switching applications such as power switches for pulse-width-modulated (PWM) controllers or motor/bridge drivers.

The ultrathin thin shrink small-outline package or TSSOP (PW) version fits in height-restricted places where other P-channel MOSFETs cannot. The size advantage is especially important where board height restrictions do not allow for an small-outline integrated circuit (SOIC) package. Such applications include notebook computers, personal digital assistants (PDAs), cellular



NC - No internal connection

telephones, and PCMCIA cards. For existing designs, the D-packaged version has a pinout common with other P-channel MOSFETs in SOIC packages.

AVAILABLE OPTIONS								
	PACKAGED							
Tj	SMALL OUTLINE (D)							
-40°C to 150°C	TPS1101D	TPS1101PWLE	TPS1101Y					

AVAILARI E ODTIONS

[†]The D package is available taped and reeled. Add an R suffix to device type (e.g., TPS1101DR). The PW package is only available left-end taped and reeled (indicated by the LE suffix on the device type; e.g., TPS1101PWLE). The chip form is tested at 25°C.



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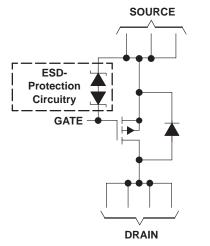
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1

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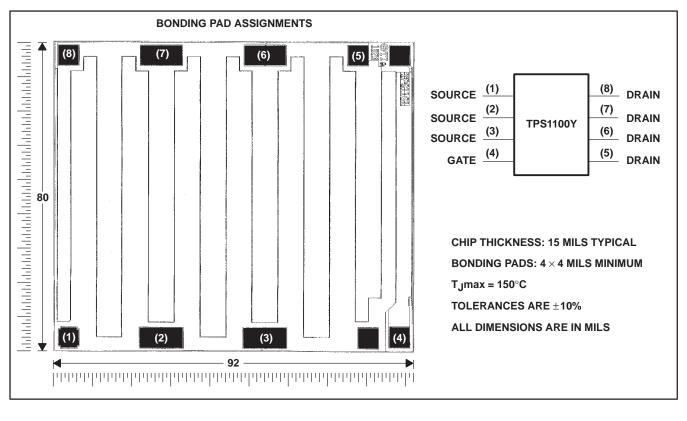
schematic



NOTE A: For all applications, all source terminals should be connected and all drain terminals should be connected.

TPS1101Y chip information

This chip, when properly assembled, displays characteristics similar to the TPS1101. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.





SLVS079C – DECEMBER 1993 – REVISED AUGUST 1995

absolute maximum ratings over operating free-air temperature (unless otherwise noted)[†]

					UNIT
Drain-to-source voltage, VDS				– 15	V
Gate-to-source voltage, VGS	2 or – 15	V			
		Dinaskaga	$T_A = 25^{\circ}C$	±0.62	
		D package	T _A = 125°C	±0.39	
	$V_{GS} = -2.7 V$	PW package	$T_A = 25^{\circ}C$	±0.61	
		г үүраскауе	$T_A = 125^{\circ}C$	±0.38	
		D package	$T_A = 25^{\circ}C$	±0.88	
		раскауе	$T_A = 125^{\circ}C$	±0.47	
	V _{GS} = -3 V	PW package	$T_A = 25^{\circ}C$	±0.86	
Continuous drain current (T _J = 150°C), I _D [‡]			$T_A = 125^{\circ}C$	±0.45	A
	V _{GS} = -4.5 V	D package	$T_A = 25^{\circ}C$	±1.52	
			$T_A = 125^{\circ}C$	±0.71	
		PW package	$T_A = 25^{\circ}C$	±1.44	
			$T_A = 125^{\circ}C$	±0.67	
		D package	$T_A = 25^{\circ}C$	±2.30	
	V _{GS} = -10 V		$T_A = 125^{\circ}C$	±1.04	
	VGS = - 10 V	PW package	$T_A = 25^{\circ}C$	±2.18	
		г үүраскауе	$T_A = 125^{\circ}C$	±0.98	
Pulsed drain current, ID [‡]			$T_A = 25^{\circ}C$	±10	А
Continuous source current (diode conduction	n), IS		$T_A = 25^{\circ}C$	-1.1	А
Storage temperature range, T _{Stg}	-55 to 150	°C			
Operating junction temperature range, T_J	-40 to 150	°C			
Operating free-air temperature range, T _A –40 to					
Lead temperature 1,6 mm (1/16 inch) from c	ase for 10 secon	ds		260	°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

[‡] Maximum values are calculated using a derating factor based on $R_{\theta JA} = 158^{\circ}C/W$ for the D package and $R_{\theta JA} = 176^{\circ}C/W$ for the PW package. These devices are mounted on an FR4 board with no special thermal considerations.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR [‡] ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D	791 mW	6.33 mW/°C	506 mW	411 mW	158 mW
PW	710 mW	5.68 mW/°C	454 mW	369 mW	142 mW

[‡] Maximum values are calculated using a derating factor based on $R_{\theta JA} = 158^{\circ}C/W$ for the D package and $R_{\theta JA} = 176^{\circ}C/W$ for the PW package. These devices are mounted on an FR4 board with no special thermal considerations.



SLVS079C - DECEMBER 1993 - REVISED AUGUST 1995

electrical characteristics at $T_J = 25^{\circ}C$ (unless otherwise noted)

static

PARAMETER TEST CONDITIO					-	TPS1101		Т	PS1101Y	,	UNIT	
	PARAMETER		MIN	TYP	MAX	MIN	TYP	MAX	UNIT			
VGS(th)	Gate-to-source threshold voltage	$V_{DS} = V_{GS}$,	I _D = −250 μ	ıA	-1	-1.25	-1.5		-1.25		V	
V _{SD}	Source-to-drain voltage (diode-forward voltage)†	I _S = -1 A,	V _{GS} = 0 V			-1.04			-1.04		V	
IGSS	Reverse gate current, drain short circuited to source	V _{DS} = 0 V,	V _{GS} = -12	V			±100				nA	
	Zero-gate-voltage drain			T _J = 25°С			-0.5					
IDSS	current	$V_{DS} = -12 V,$	VGS = 0 V	TJ = 125°C			-10				μA	
		$V_{GS} = -10 V$	I _D = -2.5 A			90			90			
	Static drain-to-source	V _{GS} = -4.5 V	I _D = -1.5 A			134	190		134			
^r DS(on)	on-state resistance [†]	$V_{GS} = -3 V$				198	310		198		mΩ	
		$V_{GS} = -2.7 V$	$I_{D} = -0.5 \text{ A}$	$I_{D} = -0.5 \text{ A}$		232	400		232			
9fs	Forward transconductance [†]	V _{DS} = -10 V,	I _D = -2 A			4.3			4.3		S	

[†] Pulse test: pulse duration \leq 300 µs, duty cycle \leq 2%

dynamic

	PARAMETER		TEST CONDITIONS		TPS1101, TPS1101Y			UNIT
	FARAIMETER		TEST CONDITIONS	MIN	TYP	MAX		
Qg	Total gate charge					11.25		
Qgs	Gate-to-source charge	$V_{DS} = -10 V,$	$V_{GS} = -10 V,$	I _D = -1 A		1.5		nC
Q _{gd}	Gate-to-drain charge	1				2.6		
^t d(on)	Turn-on delay time					6.5		ns
^t d(off)	Turn-off delay time	$V_{DD} = -10 V,$	$R_{I} = 10 \Omega$,	I _D = -1 A,		19		ns
tr	Rise time	R _G = 6 Ω,	See Figures 1 and 2			5.5		
t _f	Fall time]				13		ns
^t rr(SD)	Source-to-drain reverse recovery time	I _F = 5.3 A,	di/dt = 100 A/µs			16		



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PARAMETER MEASUREMENT INFORMATION

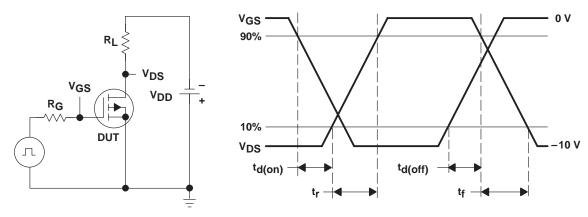


Figure 1. Switching-Time Test Circuit

Figure 2. Switching-Time Waveforms

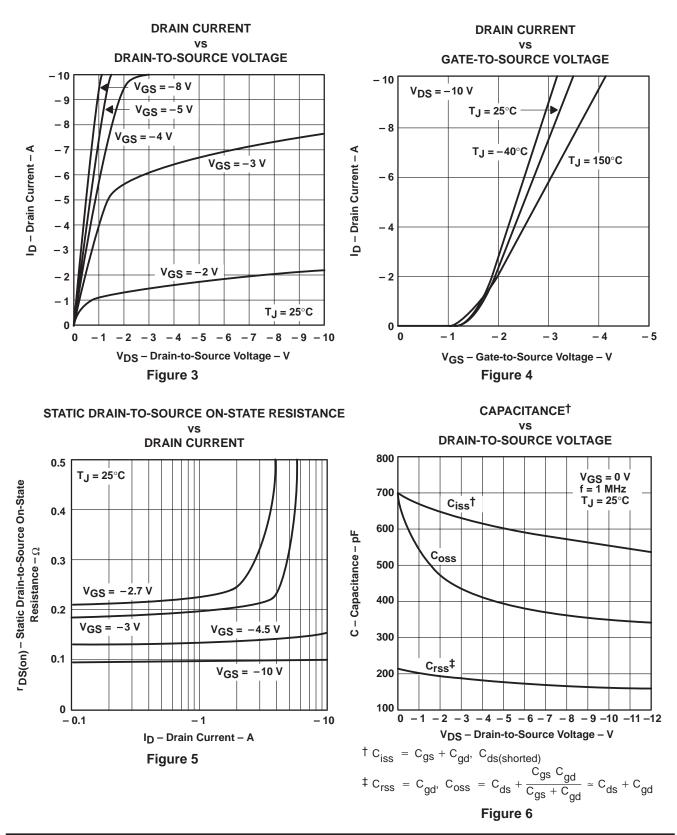
TYPICAL CHARACTERISTICS

Table of Graphs

		FIGURE
Drain current	vs Drain-to-source voltage	3
Drain current	vs Gate-to-source voltage	4
Static drain-to-source on-state resistance	vs Drain current	5
Capacitance	vs Drain-to-source voltage	6
Static drain-to-source on-state resistance (normalized)	vs Junction temperature	7
Source-to-drain diode current	vs Source-to-drain voltage	8
Static drain-to-source on-state resistance	vs Gate-to-source voltage	9
Gate-to-source threshold voltage	vs Junction temperature	10
Gate-to-source voltage	vs Gate charge	11



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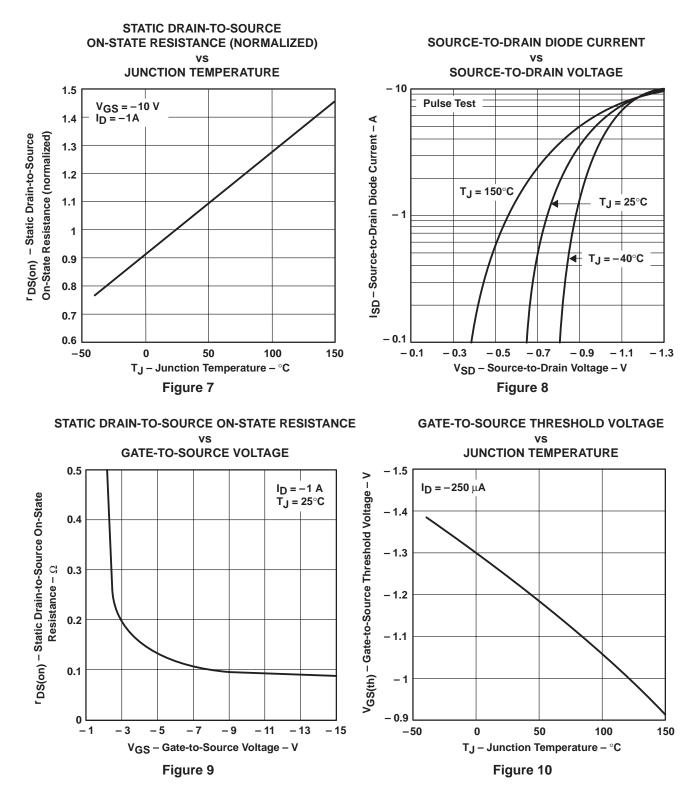


TYPICAL CHARACTERISTICS



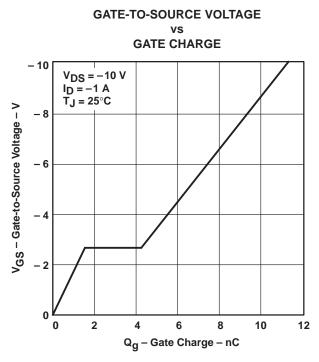
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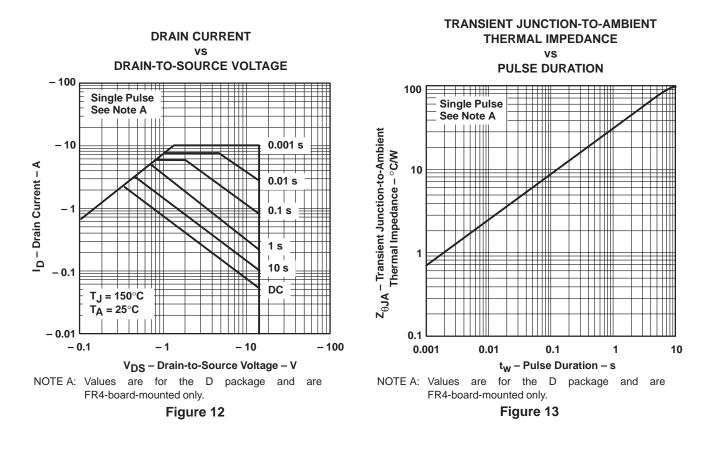
TYPICAL CHARACTERISTICS

Figure 11



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THERMAL INFORMATION



APPLICATION INFORMATION

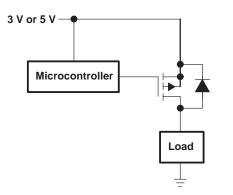


Figure 14. Notebook Load Management

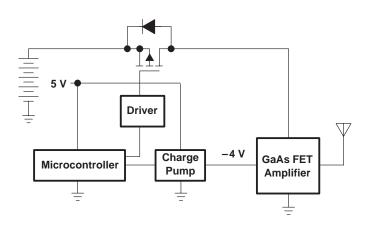


Figure 15. Cellular Phone Output Drive





10-Jun-2014

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C) Device Marking (4/5)	Samples
TPS1101D	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	1101	Samples
TPS1101DG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	1101	Samples
TPS1101DR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	1101	Samples
TPS1101DRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	1101	Samples
TPS1101PWLE	OBSOLETE	TSSOP	PW	16		TBD	Call TI	Call TI		
TPS1101PWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	PS1101	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



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PACKAGE OPTION ADDENDUM

10-Jun-2014

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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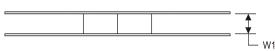
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TAPE AND REEL INFORMATION

REEL DIMENSIONS

Texas Instruments





TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

*All dimensions are nominal	

TAPE AND REEL INFORMATION

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS1101DR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TPS1101PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

14-Jul-2012



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS1101DR	SOIC	D	8	2500	340.5	338.1	20.6
TPS1101PWR	TSSOP	PW	16	2000	367.0	367.0	35.0

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